Search Notes

| Application/Control No. | Applicant(s)/Patent und Reexamination | ler |
|-------------------------|---------------------------------------|-----|
| 10/757,242 | BAILEY ET AL. | |
| Examiner | Art Unit | |
| Linh V. Nguyen | 2819 | |

| SEARCHED | | | | |
|----------|--------------------------------------|-----------|----------|--|
| Class | Subclass | Date | Examiner | |
| 330 | 252,253 254,257 263,269 330 | 3/29/2006 | LN | |
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| INTERFERENCE SEARCHED | | | | |
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| SEARCH NOTES (INCLUDING SEARCH STRATEGY) | | | |
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